Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/919,538	BABKA ET AL.	
Examiner	Art Unit	
VAN H. NGUYEN	2194	

	SEARCHED				
Class	Subclass	Date	Examiner		
709	204, 205	12/22/2006	VN		
709	224-226	12/22/2006	VN		
719	310, 316	12/22/2006	VN		
719	321-323	12/22/2006	VN		
719	327, 328	12/22/2006	VN		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
709	204	12/22/2006	VN		
719	321	12/22/2006	VN		
USPT-PGPB		12/22/2006	VN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
CONSULTED WITH KAKALI CHAKI, WQAS 2100	12/19/2006	VN		
CONSULTED WITH VIETVU, PRIMARY AU 2154	12/20/2006	VN		
INVENTOR NAME SEARCH (SEE SEARCH HISTORY PRINTOUT)	12/22/2006	VN		
WEST UPDATED (SEE SEARCH HISTORY PRINTOUT)	12/22/2006	VN		
NPL: GOOGLE, IEEE (SEE SEARCH HISTORY PRINTOUT)	12/22/2006	VN		
INTERFERENCE SEARCH (SEE SEARCH HISTORY PRINTOUT)	12/22/2006	VN`		